FAIRCHILD

# 20V P-Channel PowerTrench<sup>®</sup> MOSFET

#### **General Description**

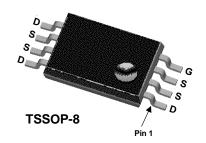
This P-Channel 1.8V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

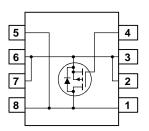
## Applications

- Power management
- Load switch

### Features

- -4.5 A, -20 V.  $R_{DS(ON)} = 47 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$  $R_{DS(ON)} = 65 \text{ m}\Omega @ V_{GS} = -2.5 \text{ V}$  $R_{DS(ON)} = 100 \text{ m}\Omega @ V_{GS} = -1.8 \text{ V}$
- $R_{DS(ON)}$  rated for use with 1.8 V logic
- Low gate charge (13nC typical)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- Low profile TSSOP-8 package





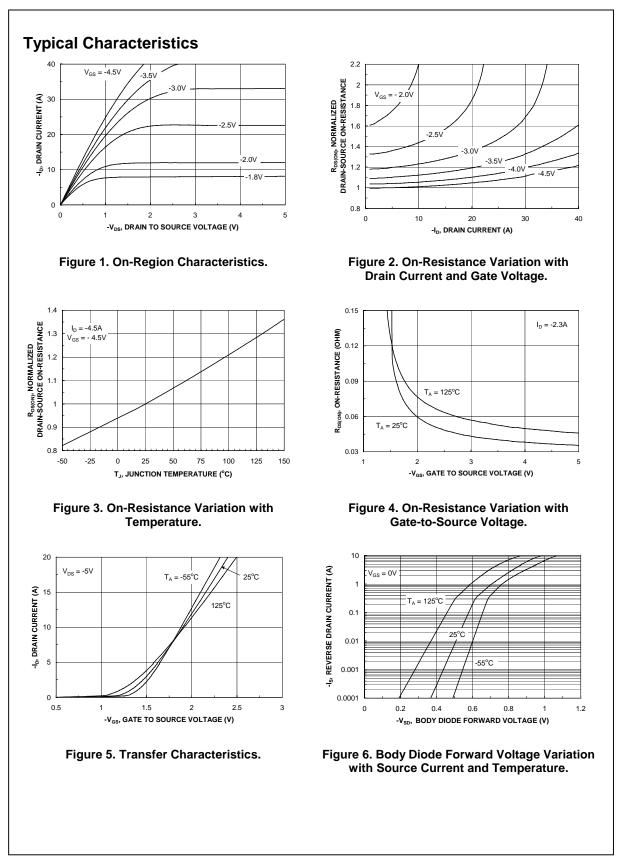
# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

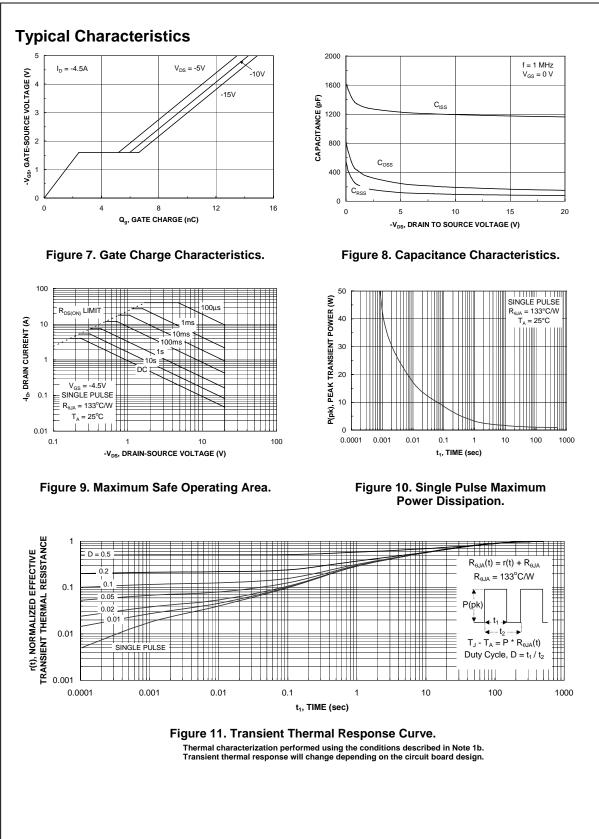
Symbol	Parameter			Ratings	Units	
V <sub>DSS</sub>	Drain–Source Voltage			-20	V	
V <sub>GSS</sub>	Gate-Source Voltage			±8		
l <sub>D</sub>	Drain Current – Contin	uous	(Note 1a)	-4.5	A	
	- Pulsec	1		-40		
P <sub>D</sub>	Power Dissipation for Si	ngle Operation	(Note 1a)	1.3	W	
			(Note 1b)	0.6		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		ure Range	-55 to +150		
Therma	I Characteristics					
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a			87		
			(Note 1b)	133	°C/W	
	e Marking and O					
	Marking Devic	ce Re	el Size	Tape width	Quantity	
Device	•					

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV<sub>DSS</sub></u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu A$ , Referenced to 25°C		-14		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V},  V_{GS} = 0 \text{ V}$			-1	μA
IGSSF	Gate-Body Leakage, Forward	$V_{GS} = 8 V$ , $V_{DS} = 0 V$			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -8 V$ $V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)	•				
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	-0.4	-0.8	-1.5	V
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A},$ Referenced to 25°C		2.5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source	$V_{GS} = -4.5 \text{ V},  I_D = -4.5 \text{ A}$		37	47	mΩ
	On-Resistance	$V_{GS} = -2.5 \text{ V},  I_D = -3.7 \text{ A}$		50	65	
		$V_{GS} = -1.8 \text{ V},  I_D = -3 \text{ A}$		77	100	
1	On State Drain Current	$V_{GS}$ =-4.5 V, $I_D$ =-4.5A, $T_J$ =125°C	20	48	65	^
l <sub>D(on)</sub>	On–State Drain Current Forward Transconductance	$V_{GS} = -4.5 V,$ $V_{DS} = -5 V$ $V_{DS} = -5 V,$ $I_{D} = -4.5 A$	-20	40		A S
9 <sub>FS</sub>		$V_{DS} = -3 V$ , $I_D = -4.3 A$		16		3
	Characteristics		1			
Ciss	Input Capacitance	$V_{DS} = -10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1193		pF
Coss	Output Capacitance	f = 1.0 MHz		193		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			96		pF
	g Characteristics (Note 2)	1				
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -10 V$ , $I_D = -1 A$ , $V_{GS} = -4.5 V$ , $R_{GEN} = 6 \Omega$		11	20	ns
t <sub>r</sub>	Turn–On Rise Time	$V_{GS} = -4.5 \text{ V},  R_{GEN} = 6 \Omega$		9	18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			36	57	ns
t <sub>f</sub>	Turn–Off Fall Time			19	34	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V},  I_D = -4.5 \text{ A},$		13	18	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -4.5 V$		2.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			3.6		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Source	Diode Forward Current			-1.1	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = -1.1 A$ (Note 2)		-0.7	-1.2	V
lotes: . R <sub>θJA</sub> is the su		mal resistance where the case thermal reference is mined by the user's board design.	b) -	s the solde		surface -

FDW262P Rev C(W)





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